

**Search Notes**

Application/Control No.

10/790,777

Examiner

Christopher RoDee

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

1756

**SEARCHED**

Class	Subclass	Date	Examiner
430	111.4 108.1	2/28/2006	CDR

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East seach enclsoed	2/27/2006	CDR